

Integrated Silicon Carbide Photonics for Color Center-based quantum technology and classical applications

Martin Hofmann¹, Patrick Berwian¹, Toby Bi², Fabian Magerl³, Julietta Förthner^{1,3}, Marina Scharin-Mehlmann¹, Christian Gobert¹, Michael Seidel¹, Christophe Pixius¹, Eberhard Bär¹, Pascal Del'Haye², Jörg Schulze^{1,3}

¹ Fraunhofer Institute for Integrated Systems and Device Technology (IISB), Erlangen, Germany

² Max-Planck-Institute for the Science of Light (MPL), Erlangen, Germany

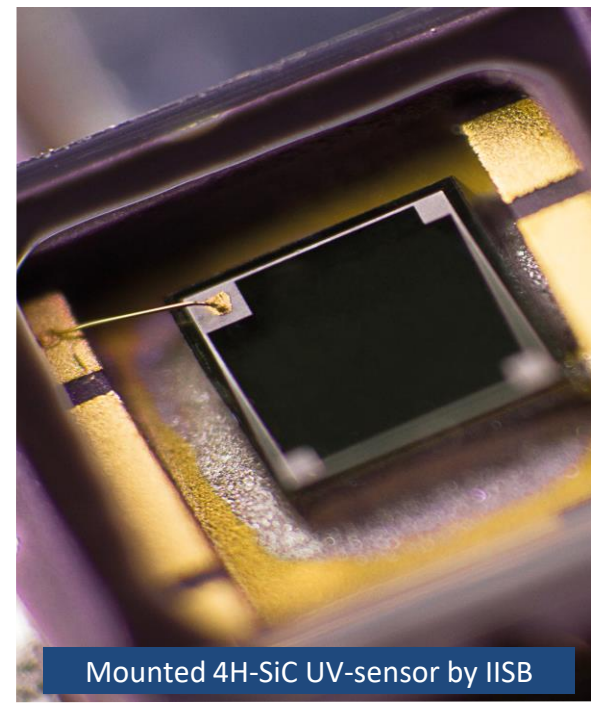
³ Chair of Electron Devices, Friedrich-Alexander-University, Erlangen, Germany

Mature semiconductor technology

Huge demand in SiC power electronics, due to electrification of industry and consumer market

SiC offers high quality substrates and device technology with:

- Large bandgap (2.4 eV – 3.2 eV)
- 8" wafer availability
- CMOS compatibility
- Customizable material properties by means of epitaxy



QT with Color Center Spin Qubits

Color centers are point defects in semiconductors

Provide a spin system that can be...

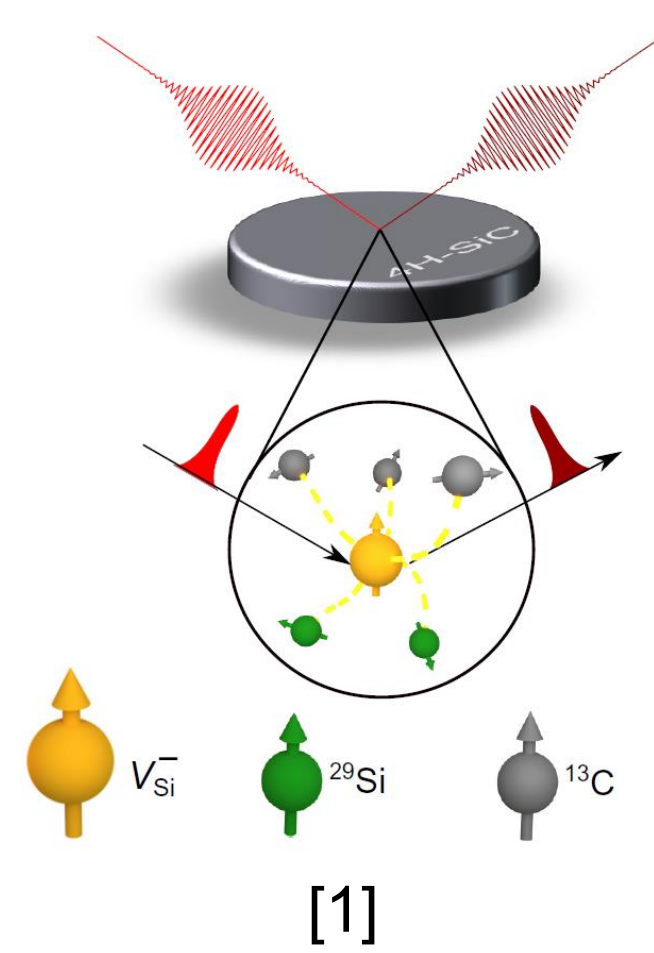
- initialized
- manipulated
- read out via PL

... using a spin-optical interface

SiC QT operation temperature above 4K (even RT)

-> Other platforms operate often in range of few mK

-> Different use cases possible



[1]

Photonics capability

Low waveguide losses possible (comparable to Si)

Nonlinear optics

Integration of electronics into photonics possible

	Si	LN	SiC	SiN
Transparent window (μm)	1,1-5,5	0,35-5,5	0,37-5,6	0,4-6,7
Refractive index	3,5	2,2	2,5-2,7	2
Second-order nonlinearities (pm/V)	-	27	12	-
Electro-optic coefficient (pm/V)	Carrier plasma effect	30,8	1,8	Close to 0
Third-order nonlinearities (x10 ⁻²⁰ m ² /W)	400	18	23-91	25
Waveguide losses (dB/cm)	0,3	0,027	0,38	0,01

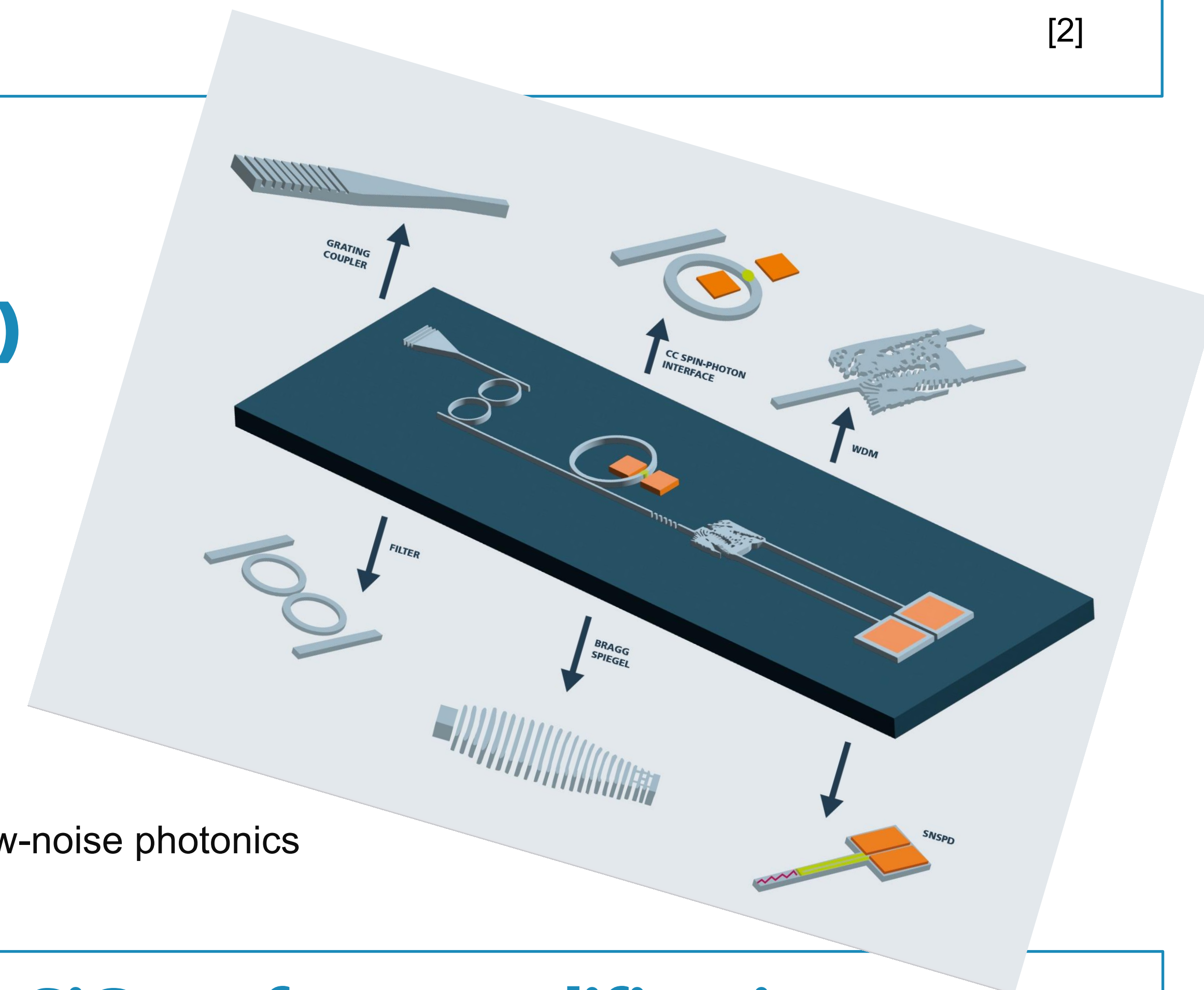
[2]

Silicon Carbide is an excellent platform for (Quantum) Photonics Technology

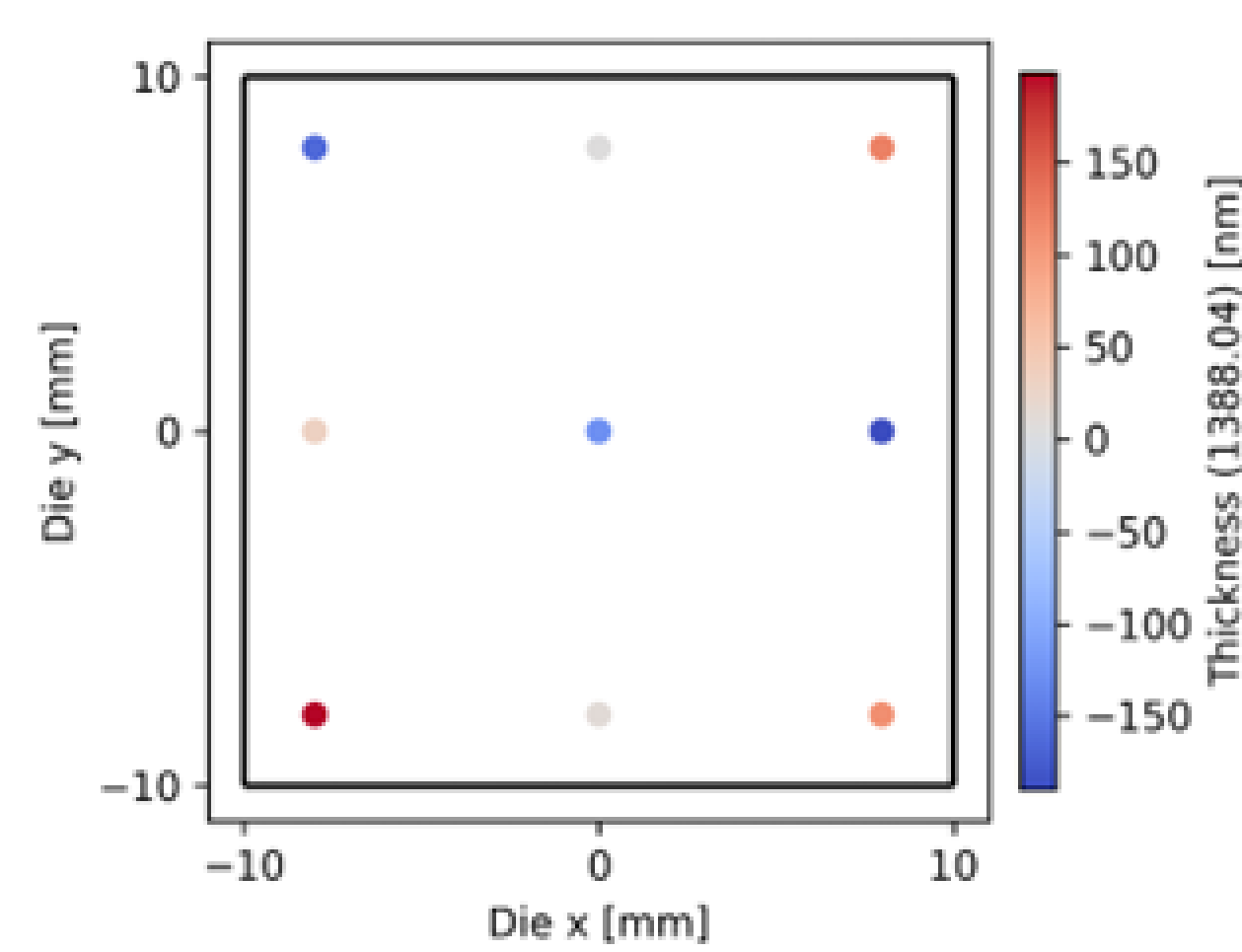
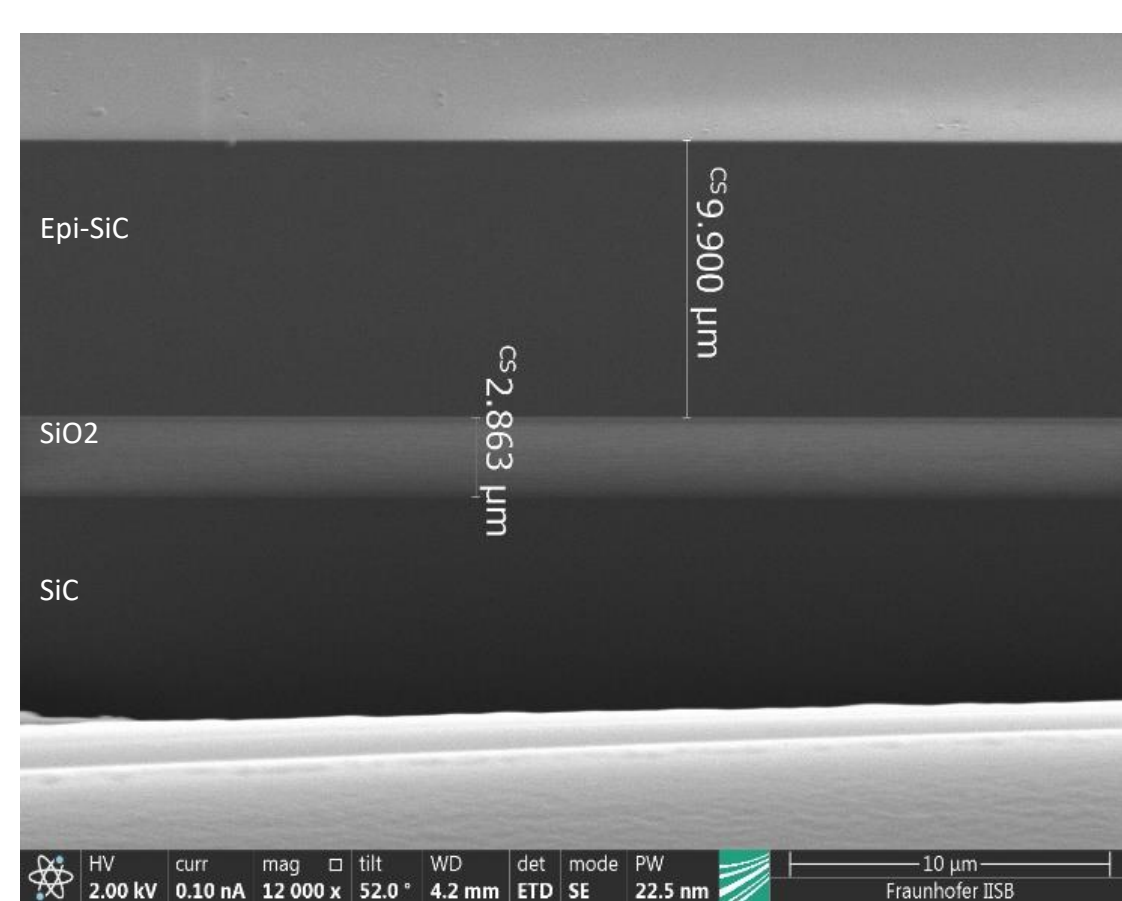
Integrated Photonics and Color Centers allow basic devices such as switches, waveguides, filters and diodes up to complex quantum photonic integrated circuits (QPIC) on the same chip

Three substantial challenges must be addressed:

- Fabrication of SiC-on-Insulator (SiCOI) stacks, for light confinement
- Optimization of material interfaces and suppression of surface-related optical background for low-loss and low-noise photonics
- Demonstration of integrated photonics for e.g., color center tuning by Stark shift or electro-optic modulators



SiCOI substrate fabrication



Thin-film SiCOI substrates for quantum photonic device production are available.

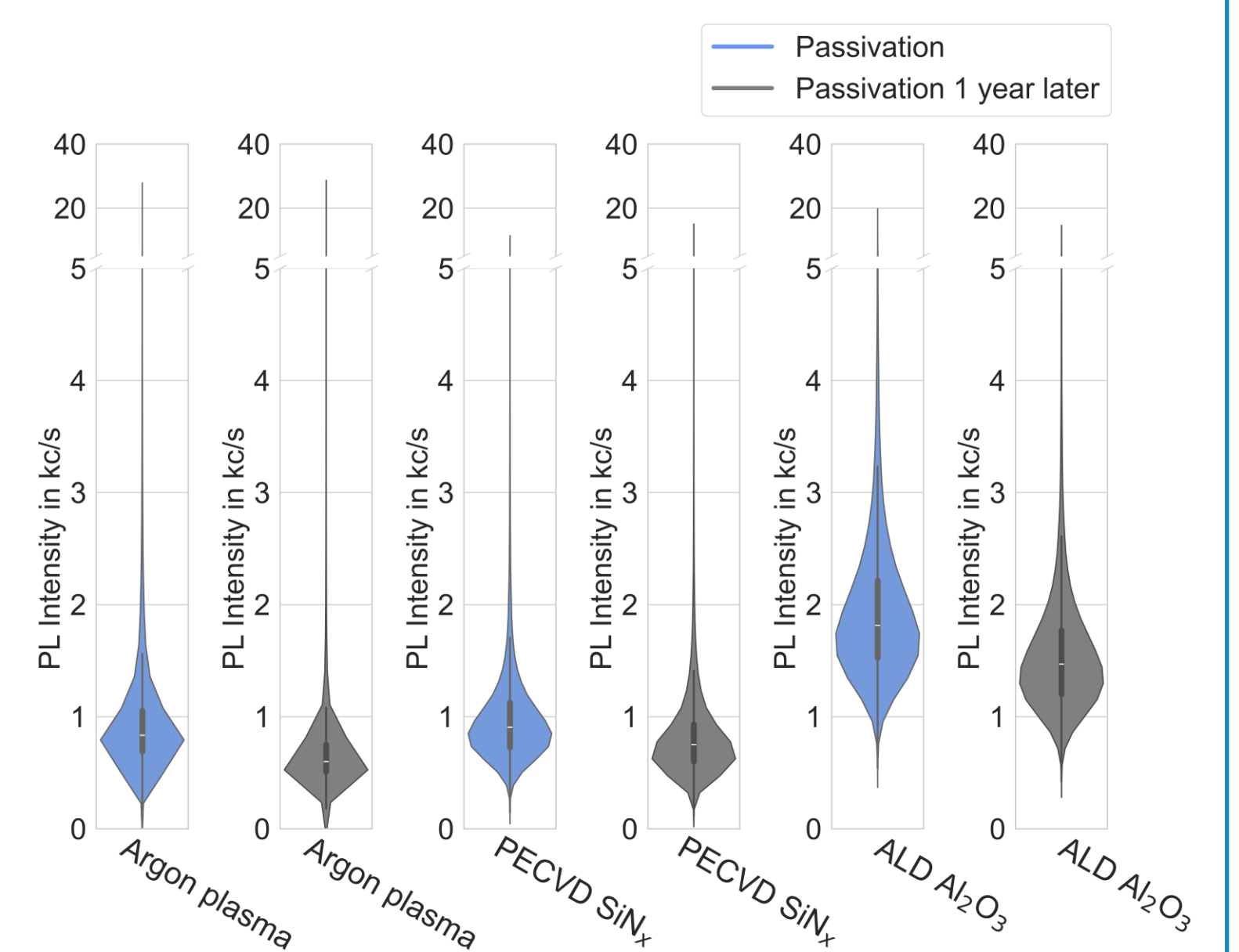
Fabrication scheme contains wafer bonding, grinding, CMP and RIE thinning

SiC surface modification

Comparative study of Al₂O₃, Si₃N₄ and SiO₂ dielectric passivation layers on SiC, including plasma-modified surfaces.

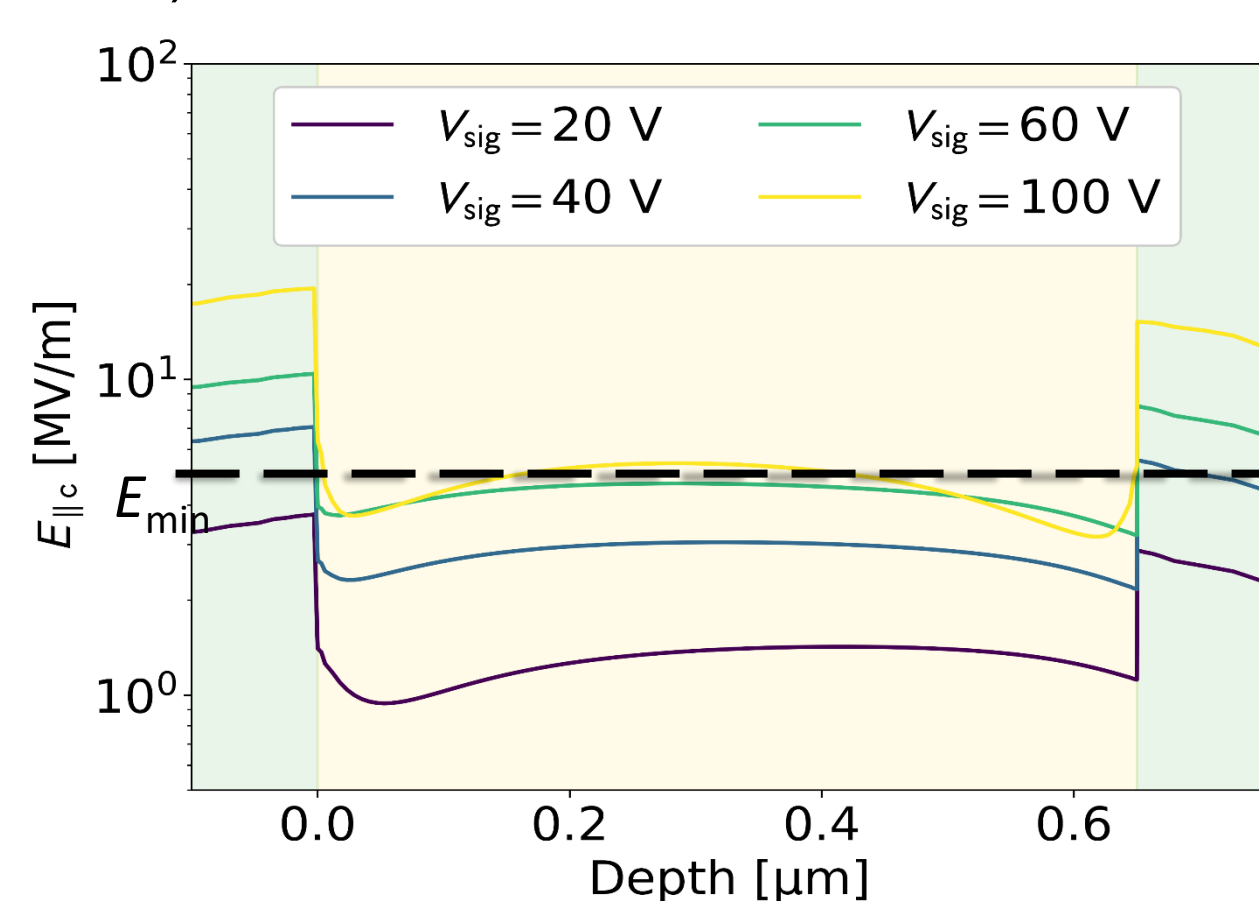
Proper passivation enables chemically stable SiC surfaces with reduced optical background.

Atomic layer etching (ALE) of SiC for waveguide smoothing → Poster number 14100-79

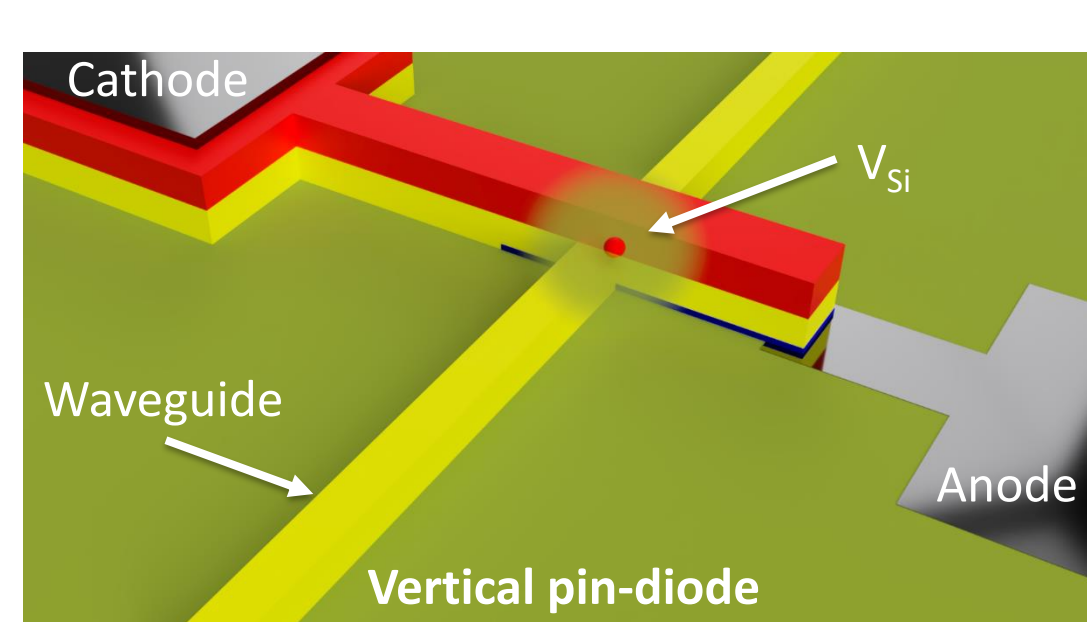
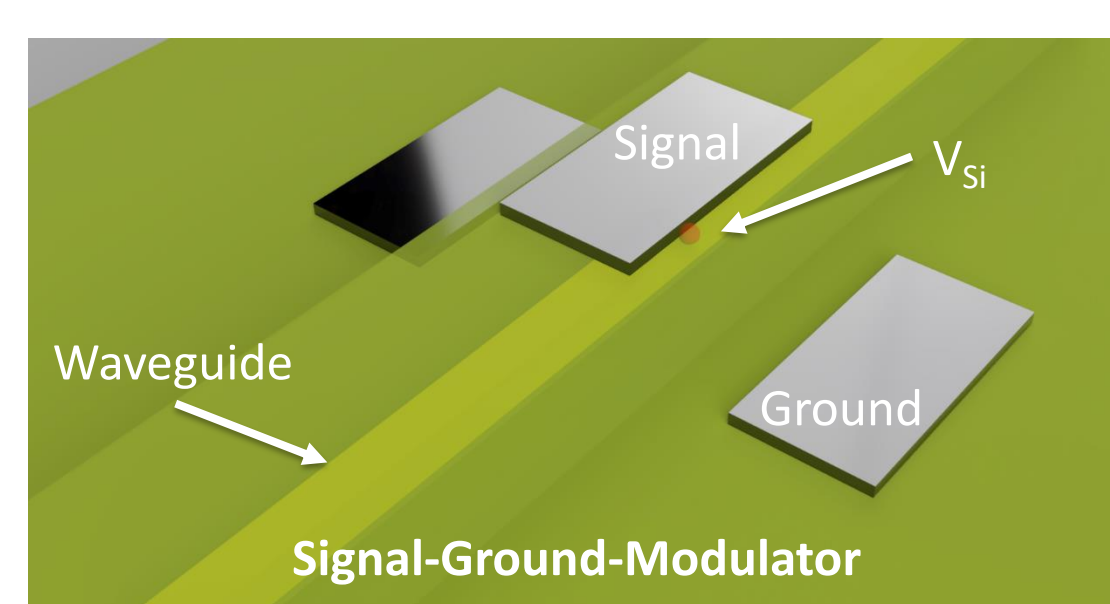


Novel device design for (quantum) integrated photonics

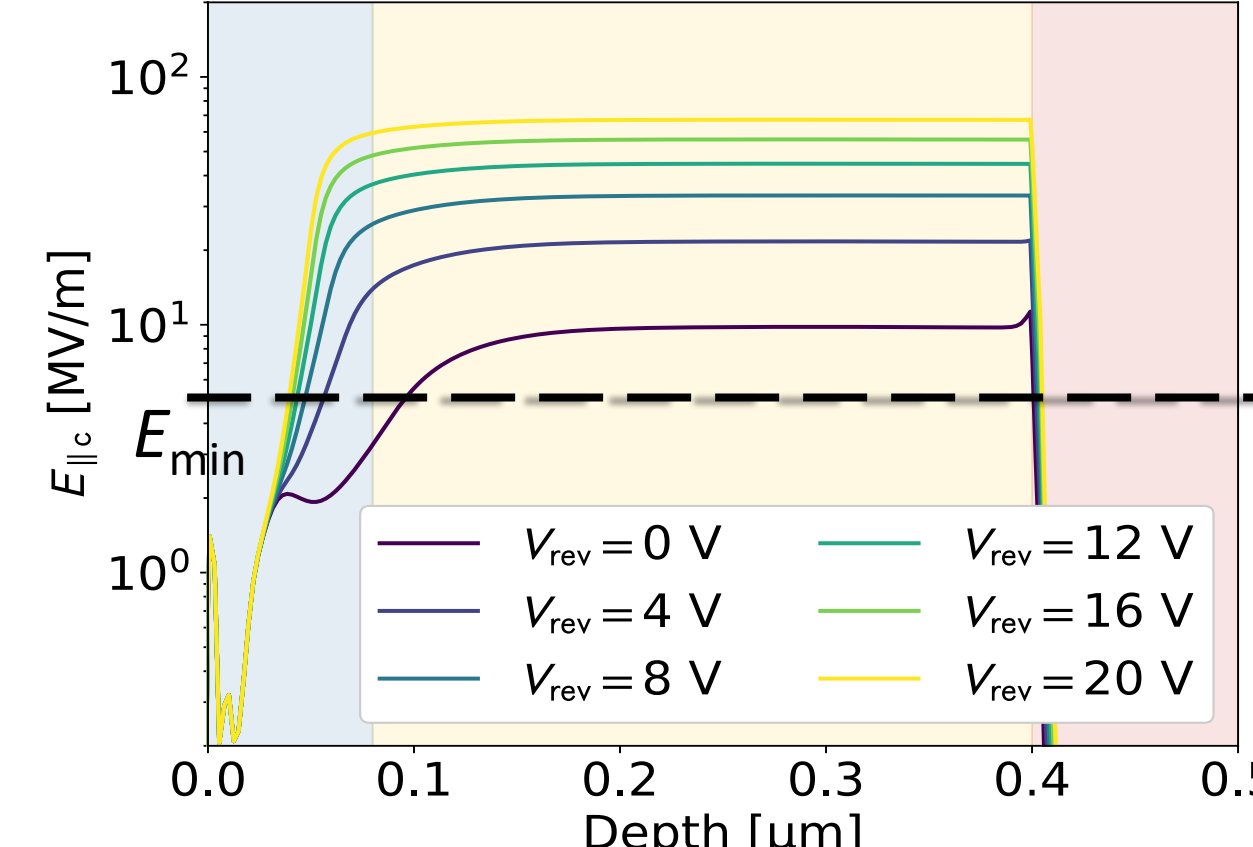
In Signal-Ground-Modulators, most of the electric field is concentrated across oxide cladding (green region in figure below)



Maximum achievable electric field strength scales with waveguide height *H* and bandgap *E_g* due to Fermi level pinning at the interfaces

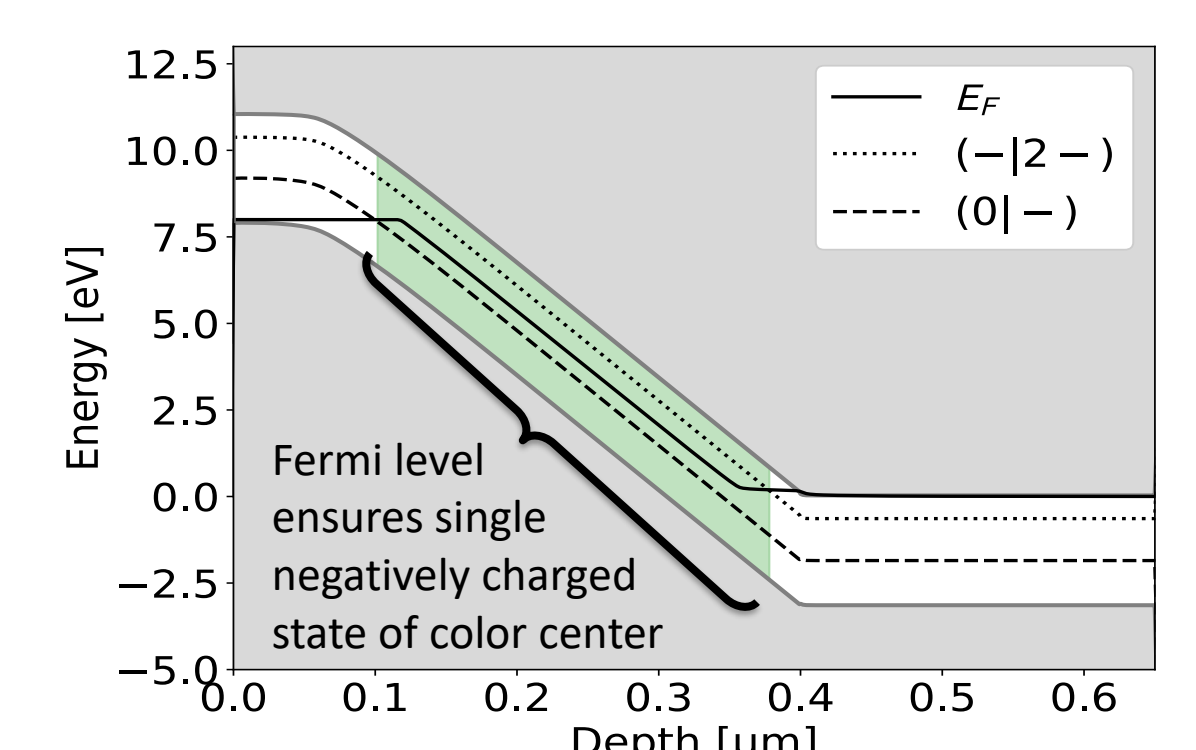


PIN-diodes have already shown promising results regarding V_{Si} Stark shift, charge state control and linewidth stabilization



Shown above, the pin-diode reaches the required field strength in the intrinsic region (yellow) at substantially lower voltages than the signal-ground-modulator, making it more suitable for quantum photonic integrated circuits

In thermal equilibrium the intrinsic layer of the pin-diode offers a wide region to host V_{Si} in optically active charge state (see green region below)



Acknowledgements

One project is part of the Munich Quantum Valley, supported by the Government of Middle Franconia (Bavaria), project number RMF-SG20-3410-7-3-3

One project is funded by the Deutsche Forschungsgesellschaft DFG as part of QuantERA project number FO1604/1-1

References

- [1] Parthasarathy et al., „Scalable Quantum Memory Nodes Using Nuclear Spins in Silicon Carbide“, Phys. Rev. Applied 19, 034026 (2023). DOI: <https://doi.org/10.1103/PhysRevApplied.19.034026>
- [2] Boretti et al., „Pioneering the future with silicon carbide integrated photonics“ Optics & Laser Technology 181 111910 (2025). DOI: <https://doi.org/10.1016/j.optlastec.2024.111910>